Power MOSFET

-60 V, -15.5 A, Single P-Channel, DPAK

Features

- Withstands High Energy in Avalanche and Commutation Modes
- Low Gate Charge for Fast Switching
- AEC Q101 Qualified NTDV20P06L
- These Devices are Pb-Free and are RoHS Compliant

Applications

- Bridge Circuits
- Power Supplies, Power Motor Controls
- DC–DC Conversion

MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise noted)

	e Continuous V _{GS} ±20 V				
	Symbol	Value	Unit		
Drain-to-Source	Voltage		V _{DSS}	-60	V
Gate-to-Source	Continu	V _{GS}	±20	V	
Voltage	Non-Repetitive	$t_p \le 10 \text{ ms}$	V _{GSM}	±30	
Continuous Drain Current	Steady State	$T_C = 25^{\circ}C$	۱ _D	-15.5	A
Power Dissipa- tion	Steady State	$T_C = 25^{\circ}C$	PD	65	W
Pulsed Drain Current	t _p = 10 μs		I _{DM}	±50	A
Operating Junctio	Dperating Junction and Storage Temperature		T _J , T _{STG}	–55 to 175	°C
	n–to–Source Aval V, V _{GS} = 5 V, I _{PK} 25 Ω)		E _{AS}	304	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		ΤL	260	°C	

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Case (Drain)	$R_{\theta JC}$	2.3	°C/W
Junction-to-Ambient - Steady State (Note 1)	R_{\thetaJA}	80	
Junction-to-Ambient - Steady State (Note 2)	R_{\thetaJA}	110	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Surface-mounted on FR4 board using 1 in sq. pad size

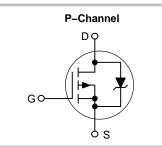
- (Cu area = 1.127 in sq. [1 oz] including traces)
 2. Surface-mounted on FR4 board using the minimum recommended pad size (Cu area = 0.412 in sq.)

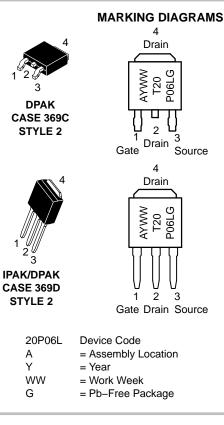


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V _{(BR)DSS}	R _{DS(on)} TYP	I _D MAX (Note 1)
–60 V	130 m Ω @ –5.0 V	–15.5 A





ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 5 of this data sheet.

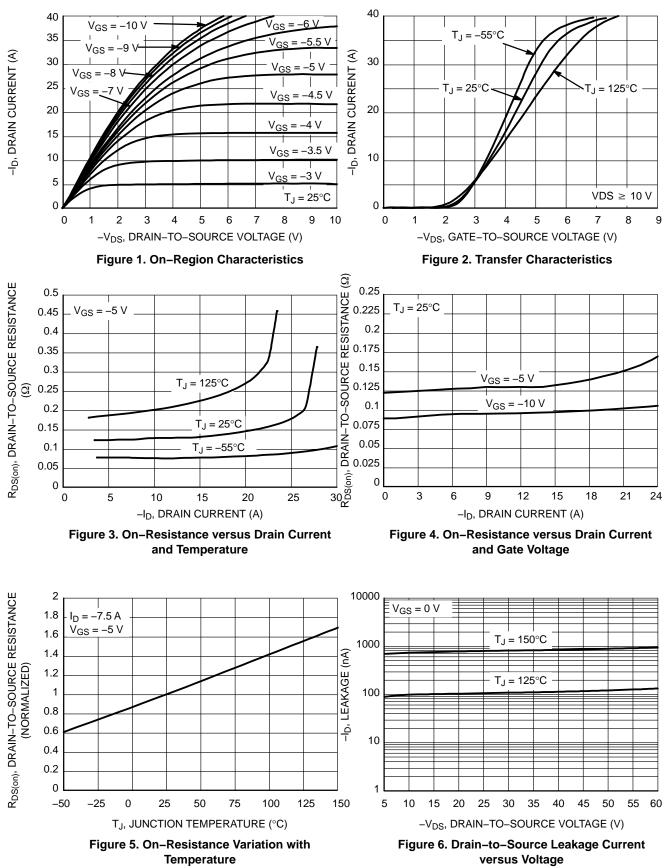
ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Condition		Min	Тур	Max	Units
OFF CHARACTERISTICS		•					-
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 V, I_D = -$	-250 μA	-60	-74		V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				-64		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{CS} = 0 V_{CS}$	$T_J = 25^{\circ}C$			-1.0	μΑ
		$V_{GS} = 0 V,$ $V_{DS} = -60 V$	$T_J = 150^{\circ}C$			-10	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} =	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 3)	•						
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = -$	–250 μA	-1.0	-1.5	-2.0	V
Gate Threshold Temperature Coefficient	V _{GS(TH)} /T _J				3.1		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = -5.0 V, I _D = -7.5 A			0.130	0.150	Ω
		V _{GS} = -5.0 V, I _D	= –15 A		0.143		
Forward Transconductance	9fs	V _{DS} = -10 V, I _D =	= –7.5 A		11		S
Drain-to-Source On-Voltage	V _{DS(on)}	V _{GS} = -5.0 V, I _D = -7.5 A	T _J = 25°C			-1.2	V
			T _J = 150°C			-1.9	
CHARGES AND CAPACITANCES		•			•		
Input Capacitance	C _{ISS}	V_{GS} = 0 V, f = 1 MHz, V_{DS} = -25 V			740	1190	pF
Output Capacitance	C _{OSS}				207	300	1
Reverse Transfer Capacitance	C _{RSS}				66	120	
Total Gate Charge	Q _{G(TOT)}				15	26	nC
Gate-to-Source Charge	Q _{GS}	$V_{GS} = -5.0 \text{ V}, V_{DS}$ $I_{D} = -18 \text{ A}$	= −48 V,		4.0		1
Gate-to-Drain Charge	Q _{GD}	$I_{\rm D} = -18 {\rm A}$			7.0		
SWITCHING CHARACTERISTICS (Note 4)						
Turn-On Delay Time	t _{d(ON)}				11	20	ns
Rise Time	tr	Vcs = -5.0 V. Vo	= -30 V.		90	180	
Turn–Off Delay Time	t _{d(OFF)}	V_{GS} = -5.0 V, V_{DD} I_D = -15 A, R_G =	= 9.1 Ω		28	50	
Fall Time	t _f				70	135	
DRAIN-SOURCE DIODE CHARACTERIS	TICS	•			•		
Forward Diode Voltage	V _{SD}		$T_J = 25^{\circ}C$		1.5	2.5	V
		$V_{GS} = 0 V, I_{S} = -15 A$	T _J = 150°C		1.3		
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 V, d_{IS}/d_t = 100 A/\mu s,$ $I_S = -12 A$			60		ns
Charge Time	t _a				39		1
Discharge Time	t _b				21		1
Reverse Recovery Charge	Q _{RR}				0.13		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL PERFORMANCE CURVES

(T_J = 25°C unless otherwise noted)



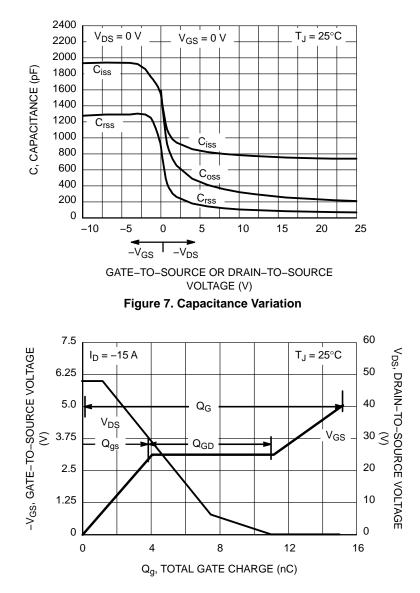
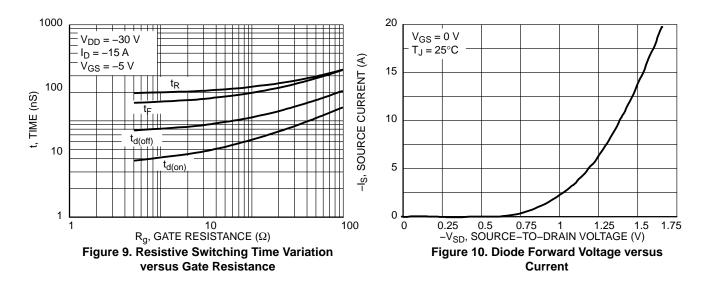
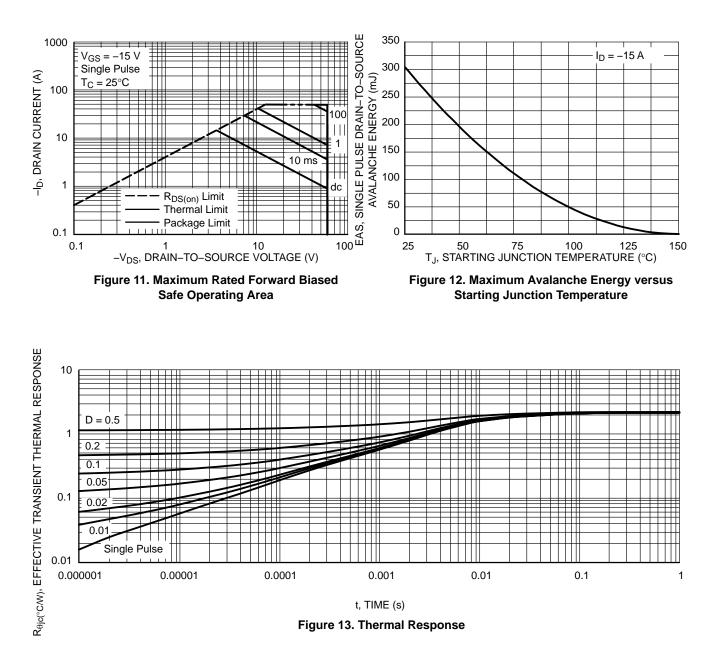


Figure 8. Gate-to-Source and Drain-to-Source Voltage versus Total Charge



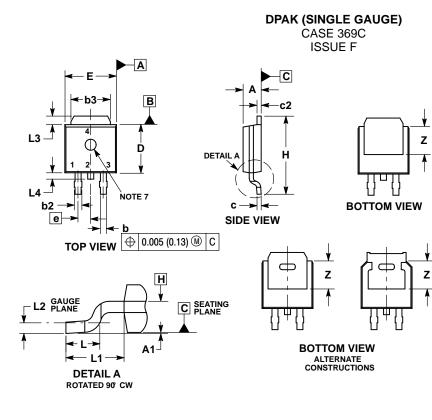


ORDERING INFORMATION

Device	Package	Shipping [†]	
NTD20P06LG	DPAK (Pb–Free)	NTD20P06LG 75 Units / Rail	
NTD20P06LT4G		2500 / Tape & Reel	
NTDV20P06LT4G		2500 / Tape & Reel	
NTDV20P06LT4G-VF01		2500 / Tape & Reel	

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS



- NOTES: 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. 2. CONTROLLING DIMENSION: INCHES. 3. THERMAL PAD CONTOUR OPTIONAL WITHIN DI-MENSIONS b3, L3 and Z. DIMENSIONS b3, L3 and Z.
- MENSIONS D3, L3 and Z. 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.
- 5. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.

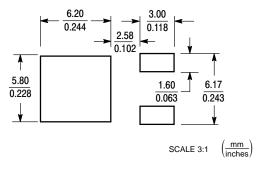
7. OPTIONA	L MOLD FEATURE.

	INCHES		MILLIN	IETERS	
DIM	MIN	MAX	MIN	MAX	
Α	0.086	0.094	2.18	2.38	
A1	0.000	0.005	0.00	0.13	
b	0.025	0.035	0.63	0.89	
b2	0.028	0.045	0.72	1.14	
b3	0.180	0.215	4.57	5.46	
С	0.018	0.024	0.46	0.61	
c2	0.018	0.024	0.46	0.61	
D	0.235	0.245	5.97	6.22	
Е	0.250	0.265	6.35	6.73	
е	0.090 BSC		2.29 BSC		
н	0.370	0.410	9.40	10.41	
L	0.055	0.070	1.40	1.78	
L1	0.114 REF		2.90 REF		
L2	0.020 BSC		0.51 BSC		
L3	0.035	0.050	0.89	1.27	
L4		0.040		1.01	
Ζ	0.155		3.93		

STYLE 2:

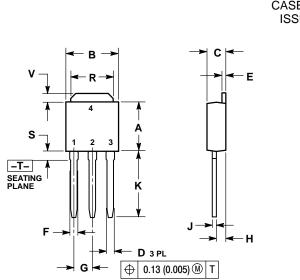
PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

SOLDERING FOOTPRINT*



*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

PACKAGE DIMENSIONS



IPAK CASE 369D **ISSUE C**

Ζ



ANSI Y14.5M, 1982 CONTROLLING DIMENSION: INCH.

	INCHES		MILLIM	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.35
в	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
Е	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.090	BSC	2.29 BSC	
н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
κ	0.350	0.380	8.89	9.65
R	0.180	0.215	4.45	5.45
S	0.025	0.040	0.63	1.01
V	0.035	0.050	0.89	1.27
Ζ	0.155		3.93	
STYL PIN		E		

2. DRAIN 3.

4 DRAIN

SOURCE

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